# **MOSFET** – Power, Single

# **P-Channel** -60 V, -6 A, 260 mΩ

#### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVTFS5124PLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V <sub>DSS</sub>	-60	٧		
Gate-to-Source Voltage	€		V <sub>GS</sub>	±20	٧
Continuous Drain Cur-		T <sub>mb</sub> = 25°C	I <sub>D</sub>	-6.0	Α
rent R $_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady	T <sub>mb</sub> = 100°C		-4.0	
Power Dissipation	State	State T <sub>mb</sub> = 25°C		18	W
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		T <sub>mb</sub> = 100°C		9.0	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.4	Α
rent $R_{\theta JA}$ (Notes 1, 3, 4)	Steady State	T <sub>A</sub> = 100°C		-1.7	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.0	W
R <sub>θJA</sub> (Notes 1, 3)		T <sub>A</sub> = 100°C		1.5	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	-24	Α
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C		
Source Current (Body D	I <sub>S</sub>	-18	Α		
Single Pulse Drain-to-S Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> $I_{L(pk)}$ = -13 A, L = 0.1 m	E <sub>AS</sub>	8.5	mJ		
Lead Temperature for S (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Note 2 and 3)	$R_{\Psi J-mb}$	8.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	49.2	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

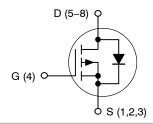


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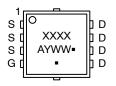
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
-60 V	260 mΩ @ -10 V	-6 A	
	380 mΩ @ -4.5 V	-0A	

#### P-Channel MOSFET





#### WDFN8 (μ8FL) CASE 511AB



**MARKING DIAGRAM** 

XXXX = Specific Device Code A = Assembly Location Y = Year

WW = Work Week
■ Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

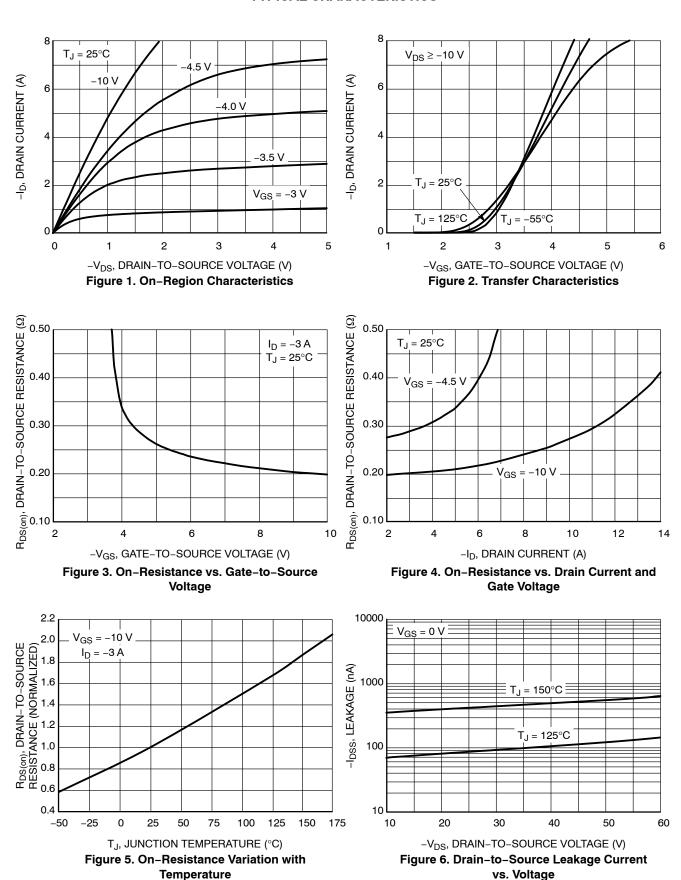
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS					-	•	-	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1.0	μΑ	
		$V_{DS} = -60 \text{ V}$	T <sub>J</sub> = 125°C			-10		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	s = ±20 V			±100	nA	
ON CHARACTERISTICS (Note 5)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= -250 μA	-1.5		-2.5	V	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V},$	I <sub>D</sub> = -3 A		200	260	mΩ	
		$V_{GS} = -4.5 V$	I <sub>D</sub> = -3 A		290	380		
Forward Transconductance	9FS	$V_{DS} = -15 V$ ,	I <sub>D</sub> = -5 A	4			S	
CHARGES AND CAPACITANCES								
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -25 \text{ V}$			250			
Output Capacitance	C <sub>oss</sub>				27		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>				17			
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -3 \text{ A}$			3.5		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.4			
Gate-to-Source Charge	$Q_{GS}$				1.2			
Gate-to-Drain Charge	$Q_{GD}$				1.9			
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -3 \text{ A}$			6		1	
SWITCHING CHARACTERISTICS (No	te 6)				•	•		
Turn-On Delay Time	t <sub>d(on)</sub>				7			
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V. V	ne = -48 V.		14		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = -4.5 \text{ V, V}$ $I_D = -3 \text{ A, R}_0$	$_{3}$ = 2.5 $\Omega$		13			
Fall Time	t <sub>f</sub>				10			
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	•		
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		-0.87	-1.0	V	
		$I_S = -3 A$	T <sub>J</sub> = 125°C		-0.74		1	
Reverse Recovery Time	t <sub>RR</sub>		<u> </u>		17		ns	
Charge Time	ta	$V_{GS} = 0 \text{ V},$ $dI_{S}/dt = 100 \text{ A}/\mu\text{s},$ $I_{S} = -3 \text{ A}$			14		1	
Discharge Time	t <sub>b</sub>				3		1	
Reverse Recovery Charge	Q <sub>RR</sub>				19		nC	

<sup>5.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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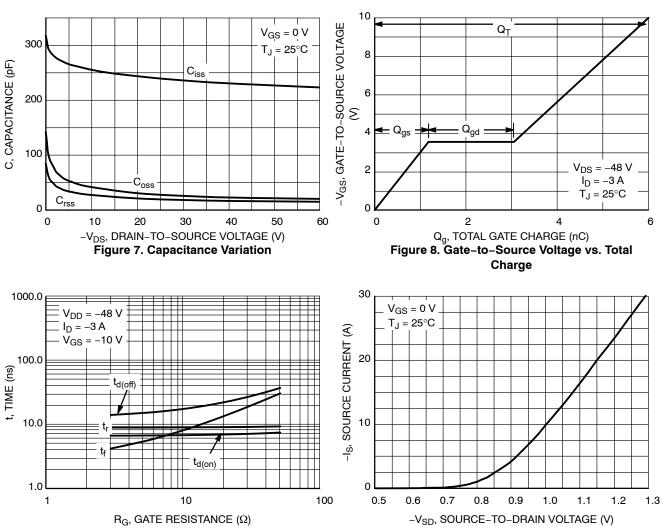


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 11. Diode Forward Voltage vs. Current

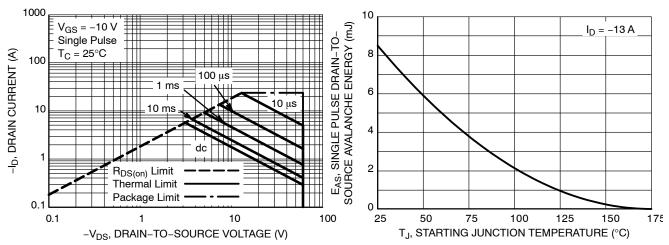


Figure 10. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**

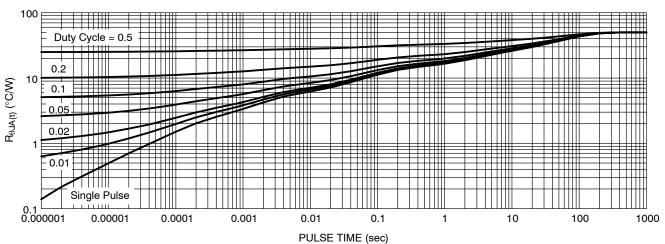


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS5124PLTAG	5124	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS5124PLWFTAG	24LW	WDFN8 (Pb–Free)	1500 / Tape & Reel
NVTFS5124PLTWG	5124	WDFN8 (Pb-Free)	5000 / Tape & Reel
NVTFS5124PLWFTWG	24LW	WDFN8 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC	;	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC			0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	(	0.026 BS	0	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



#### **GENERIC MARKING DIAGRAM\***

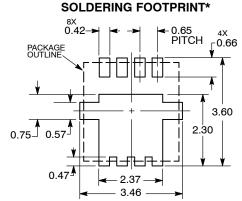


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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